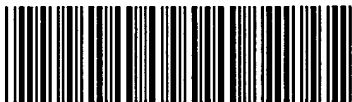


Search Notes

Application/Control No.

10/624,671

Examiner

Helen O. Chu

Applicant(s)/Patent under
Reexamination

NAKAMURA ET AL.

Art Unit

1745

SEARCHED

| Class | Subclass | Date | Examiner |
|-------|----------|----------|----------|
| 429 | 309 | 6/9/2006 | HC |
| 429 | 307 | 6/9/2006 | HC |
| 429 | 303 | 6/9/2006 | HC |
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INTERFERENCE SEARCHED

| Class | Subclass | Date | Examiner |
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**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

| | DATE | EXMR |
|---------------------------------|----------|------|
| Edan and Palm (Inventor Search) | 6/9/2006 | HC |
| East Search | 6/9/2006 | HC |
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